Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/736,739	LEBAN ET AL.	
Examiner	Art Unit	
Yong Chu	1626	

	SEAR	CHED	
Class	Subclass	Date	Examiner
562	503,504,6 22	4/24/2006	YC
514	563	4/24/2006	YC

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SI (INCLUDIN	EARCH NOTE G SEARCH S	S [RATEGY]	)
		DATE	EXMR
EAST		4/21/2006	YC
PALM		4/21/2006	YC
STN		4/21/2006	YC